

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/850,114	TAKENAGA, TAKASHI	
		Examiner	Art Unit	
		Djenane M Bayard	2141	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,263,343	07-2001	Hirono, Chiharu	707/104.1
	B	US-6,498,982	12-2002	Bellesfield et al.	701/202
	C	US-6,577,714	06-2003	Darcie et al.	379/93.17
	D	US-6,684,088	01-2004	Halahmi, Erez	455/566
	E	US-2002/0063723	05-2002	Hirono, Chiharu	345/619
	F	US-6,360,221	03-2002	Gough et al.	707/10
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.